

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST  
CERTIFICATES FOR ELECTRICAL EQUIPMENT  
(IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE  
CERTIFICATS D'ESSAIS DES EQUIPEMENTS  
ELECTRIQUES (IECEE) METHODE OC

**CB TEST CERTIFICATE****CERTIFICAT D'ESSAI OC**

Product  
Produit

Scanner

Name and address of the applicant  
Nom et adresse du demandeur

Global Scanning A/S  
SVANEVANG 2  
ALLEROED, 3450 Denmark

Name and address of the manufacturer  
Nom et adresse du fabricant

Global Scanning A/S  
SVANEVANG 2  
ALLEROED, 3450 Denmark

Name and address of the factory  
Nom et adresse de l'usine

Global Scanning A/S  
GRAESHOLMEVEJ 57  
SVENDBORG, 5700 Denmark

Note: When more than one factory, please report on page 2  
Note: Lorsque il y plus d'une usine, veuillez utiliser la 2<sup>ème</sup> page

Additional Information on page 2  
24 Vdc, 2A (optional)

Ratings and principal characteristics  
Valeurs nominales et caractéristiques principales

Global Scanning or Context

Trademark (if any)  
Marque de fabrique (si elle existe)  
Type of Manufacturer's Testing Laboratories used  
Type de programme du laboratoire d'essais  
constructeur

TC53D, TD53D, TE53D

Model / Type Ref.  
Ref. De type

Additional information (if necessary may also be  
reported on page 2)  
Les informations complémentaires (si nécessaire,,  
peuvent être indiqués sur la 2<sup>ème</sup> page

Additionally evaluated to EN 60950-1: 2006 / A11: 2009 / A1:  
2010 / A12: 2011 / A2:2013; National Differences specified in the  
CB Test Report.

A sample of the product was tested and found  
to be in conformity with  
Un échantillon de ce produit a été essayé et a été  
considéré conforme à la

Additional Information on page 2  
IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC 60950-  
1(ed.2);am2

As shown in the Test Report Ref. No. which forms  
part of this Certificate  
Comme indiqué dans le Rapport d'essais numéro de  
référence qui constitue partie de ce Certificat

E125496-A19-CB-1 issued on 2016-08-31

This CB Test Certificate is issued by the National Certification Body  
Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**



- UL (US), 333 Pflugsten Rd IL 60062, Northbrook, USA
- UL (Denko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see [www.ul.com/ncbnames](http://www.ul.com/ncbnames)

Date: 2016-08-31  
Original Issue Date: 2015-11-27

Signature:

Jan-Erik Storgaard

## Factories:

Global Scanning Suzhou Co Ltd  
Building 39, Dongjing Industrial Zone  
No. 9 Dongfu Road  
Suzhou Industrial Park  
Suzhou, 215123 Jiangsu China

## Additional Information:

The original report was modified to include the following changes/additions:

- Trademark was changed to include both Contex and Global scanning.
- Alternate model TE53D was added

**Additional information (if necessary)****Information complémentaire (si nécessaire)**

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